

Notice of References Cited	Application/Control No. 09/922,187	Applicant(s)/Patent Under Reexamination MUSA ET AL.	
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*	V	Beilstein registry #2745818, 07-1989
*	W	Beilstein registry #7031474, 05-1995
*	X	Beilstein registry #6902904, 02-1995

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